Data Sheet

500 kHz / 1 MHz Precision LCR Meter

Models 894 & 895



Industry-Leading Performance

The 894 and 895 are high accuracy LCR meters capable of measuring inductance, capacitance, and resistance of components and materials at DC or from 20 Hz to 500 kHz or I MHz respectively. These LCR meters provide flexible AC and DC test signal configuration. AC test signal voltage is variable from 5 mVrms to 2 Vrms, the AC current is adjustable up to 66.7 mArms, depending on the AC impedance selected, and a DC bias signal can be added. The vivid 4.3-inch TFT LCD offers a clear view of all measured and setting values along with BIN sorting comparator results and a handy Zoom feature that enlarges the measured values to full screen. With a basic accuracy of 0.05%, auto level control (ALC), open / short / load correction and cable length compensation, these meter are perfect tools for R&D, manufacturing and quality control applications.

DC Biasing

Both the 894 and 895 feature a DC bias source which allows the meter to apply a DC signal to the device under test to simulate in-circuit conditions.

DC biasing is commonly used to measure capacitance of ceramic, MLCC, polyester and other capacitors with high dielectric constants. These type of capacitors exhibit a significant change in capacitance with a DC voltage applied. By controlling the DC voltage, users can obtain a more deterministic measurement result. Other applications include evaluation of cored-inductors and junction capacitance of semiconductor devices.

The DC bias source is adjustable from -5V to +5V / -50 mA to +50 mA. Additionally the voltage or current levels can be swept while logging the resulting capacitance.

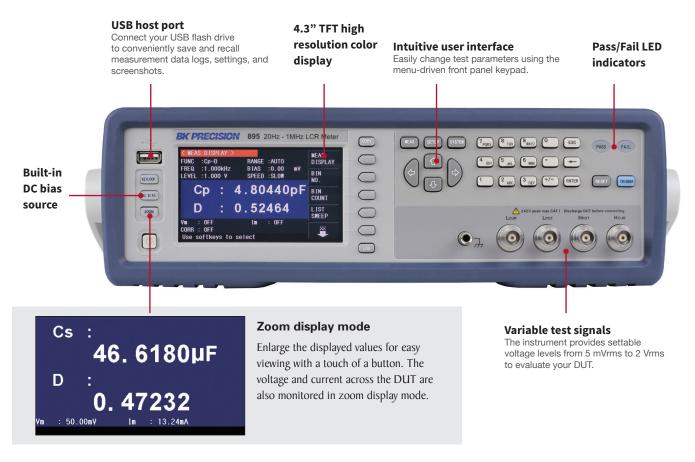
Model	894	895
Measurement parameters	L, C, R, G, X, Z, Y, B, θ, Q, D, DCR	
Basic accuracy	0.05%	
DCR measurement range	0.01 Ω - 100 ΜΩ	
Test frequency range	20 Hz - 500 kHz	20 Hz - I MHz

Features & Benefits

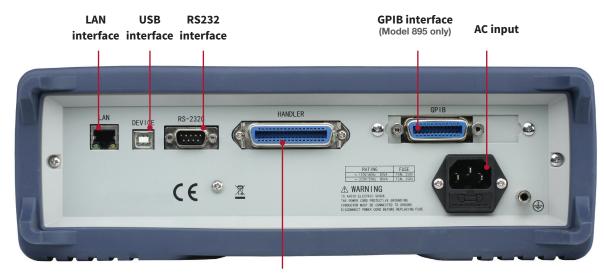
- AC test signal voltage adjustable up to 2 Vrms
- 3 AC current ranges, selectable via 30 Ω , 50 Ω or 100 Ω internal AC impedance. The 30 Ω setting provides up to 66.7 mArms of drive current, sufficient for larger inductors and transformers.
- Built-in DC bias source adjustable from
 -5V to +5V / -50 mA to +50 mA
- Fast measurement speed up to 13 ms/reading to increase manufacturing throughput
- Adjustable measurement speed for fast readout or better accuracy
- 201-point programmable list sweep function providing ability to sweep frequency, AC and DC bias voltage/current levels
- Auto-level control to maintain the measurement signal applied to the DUT at a constant level
- Test signal voltage and current monitoring
- BIN comparator function to sort components in up to 10 bin locations
- Handler interface for easy integration with a component handler
- 1 m and 2 m cable compensation
- 4-terminal fixture and Kelvin clip test leads included
- Transformer test function with optional transformer test fixture TL89TI
- Versatile trigger functionality (internal, external, bus and manual)
- Standard USB, LAN, and GPIB (895 only) interface for remote control using SCPI commands



Front panel



Rear panel

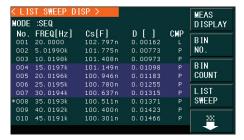


Handler interface

36-pin connector to interface with component handler via input/output control signals. Includes bin and list sweep comparator results and end of measurement (EOM) indicator output signals, external trigger, and key lock input signal.

Powerful Features

Programmable List sweep



Use the built-in linear and logarithmic sweep function, supporting up to 20I sweep points, to conveniently display, analyze and store primary and secondary parameters of a component. Sweep test frequency, AC source voltage and current levels, DC bias source voltage and current levels. A delay can be programmed after each sweep point. The list sweep can be triggered internally, manually or externally and executed in sequence or step mode.

Bin sorting function



Quickly sort components using the instrument's 9 primary BINs, a secondary BIN and out-of-specification BIN. The results can be displayed in a table on-screen or output via the handler interface. High and low limits for each bin can be set up in absolute, tolerance or sequential mode with Pass/Fail indicator.

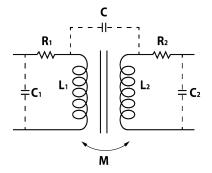
Remote PC control



Integrate your LCR meter into an automated test system and control it from a PC using SCPI commands via the RS232, USB, LAN, or GPIB (895 only) interface.

Transformer measurements (optional)

Using optional test fixture TL89TI, the 894 and 895 can test the primary and secondary inductance LI, L2, turn ratio (N, I/N), mutual inductance (M), and primary and secondary direct-current resistance (R2) of a transformer directly. Additionally, the two common transformer parameters winding equivalent capacitance C₀ and leakage inductance L_k can be characterized indirectly.



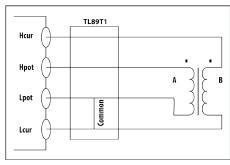
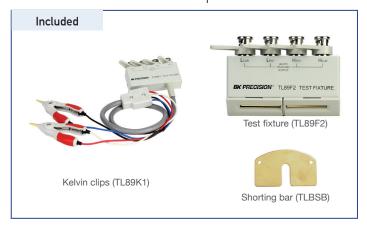


Diagram showing the TL89TI connected to a transformer under test.

Flexible test accessories

Standard accessories shipped with each unit are Kelvin clip test leads for 4-wire measurements, a test fixture, and shorting bar. The optional transformer test fixture allows users to measure transformer parameters.





Specifications

Valid after 30 minutes of warm up time, operating at 23 °C \pm 5 °C

Test Signal Frequency			
Model	Range	Minimum resolution	Accuracy
894	20 Hz - 500 kHz	0.01.42	0.01.9/
895	20 Hz - I MHz	0.01 Hz 0.01 %	

	Test Sign	nal Levels	
AC source (ALC* OFF			
Voltage Accuracy		10% x set voltage ± 2mV	
Voltage Level		Resolution	
5 mVrms - 100 mVrms		I00 μVrms	
100 mVrms - 1 Vrms		I mVrms	
I Vrms - 2 Vrms		IO mVrms	
Current Accuracy		10 % x set current ± 10 μA	
Current Range		Impedance	
I66.7 μArms	- 66.7 mArms	30 Ω	
I00.0 μArms	- 40.0 mArms	50 Ω	
50.0 μArms -	20.0 mArms	100 Ω	
AC source (ALC* ON)			
Voltage	Range	I0 mVrms – I Vrms	
	Accuracy	6% x set voltage ± 2 mV	
Current	Range	I00 μArms - I0 mArms	
Current	Accuracy	6 % x set current \pm 10 μA	
DC bias source			
	Range	-5 V to +5 V	
Voltage	Accuracy	1 % x set voltage ± 5 mV	
	Resolution	0.01 mV	
	Range	-50 mA to +50 mA	
Current	Accuracy	I % x set current ± 50 μA	
	Resolution	0. Ι μΑ	

^{*}Auto Level Control

I: Resolution and impedance see AC source (ALC OFF) specification

Measurements				
Measurement parameters		L, C, R, G, X, Z, Y, Β, θ, Q, D, DCR		
Transformer measurement parameters ²		L2A, L2B, N, I/N, M		
Basic accuracy		0.05 %		
AC source Output impedance (± 2%)		30 Ω, 50 Ω, 100 Ω		
Typical measurement time (≥10 kHz) (excluding display refresh time)	Fast	13 ms / measurement		
	Medium	67 ms / measurement		
	Slow	187 ms / measurement		
Equivalent circuit		Series, Parallel		
Range mode		Auto, Hold		
Averaging		I-255 measurements		
Correction function		Open, Short and Load correction		

^{2:} Requires optional fixture TL89TI

		Measurements	
Cable length	compensation	0, I, & 2 meters	
Math operations		Direct reading, Δ ABS, Δ %	
Trigger mode		Internal, Manual, External, Bus	
Delay time setup		Time from trigger to start: 0 to 60 seconds	
		Resolution: I ms	
Comparator (Bin sorting)		10-bin sorting, primary bins BINI-BIN9 and OUT, secondary bin AUX	
		Bin counter: 0 to 999,999	
		PASS/FAIL indication via front panel LED or handler interface signal	
	201 sweep points	Sweep test frequency, test signal AC voltage, test signal AC current, test signal DC bias voltage and test signal DC bias current	
List sweep	Measurement parameters	Primary and secondary	
	Sweep modes	Linear or logarithmic	
	Trigger mode	Sequential and Step	
	Comparator	One pair of lower and upper limits for primary or secondary parameter (user selectable)	
	non-volatile mory	Save / recall 40 setups	
		General	
External USB memory Save / recall setups, screenshots, me sweep data logs		Save / recall setups, screenshots, measurements and sweep data logs	
Remote intertace		USB (USBTMC or virtual COM), RS232, LAN, GPIB (895 only)	
Handlei	interface	36-pin connector	
AC input	Voltage	II0/220 VAC ±10%	
Aciliput	Frequency	47 – 63 Hz	
Power co		Max. 80 VA	
Operating temperature		IVIAX. OU VA	
Operating	<u> </u>	0 °C to 40 °C	
	<u> </u>		
Storage to	temperature	0 °C to 40 °C	
Storage to	temperature emperature	0 °C to 40 °C -10 °C to 70 °C	
Storage to Relative Dis	temperature emperature humidity	0 °C to 40 °C -10 °C to 70 °C Up to 80%	
Storage to Relative Dis	temperature emperature humidity splay	0 °C to 40 °C -I0 °C to 70 °C Up to 80% 4.3" TFT color display without bezel: 280 mm × 88 mm × 370 mm (II.02" x 3.46" x 14.56") with bezel: 369 mm × 108 mm × 408 mm	
Storage to Relative Dis	temperature emperature humidity splay ns (WxHxD)	0 °C to 40 °C -I0 °C to 70 °C Up to 80% 4.3" TFT color display without bezel: 280 mm × 88 mm × 370 mm (II.02" x 3.46" x I4.56") with bezel: 369 mm × 108 mm × 408 mm (I4.52" x 4.25" x I6.06") 5 kg (II lbs)	
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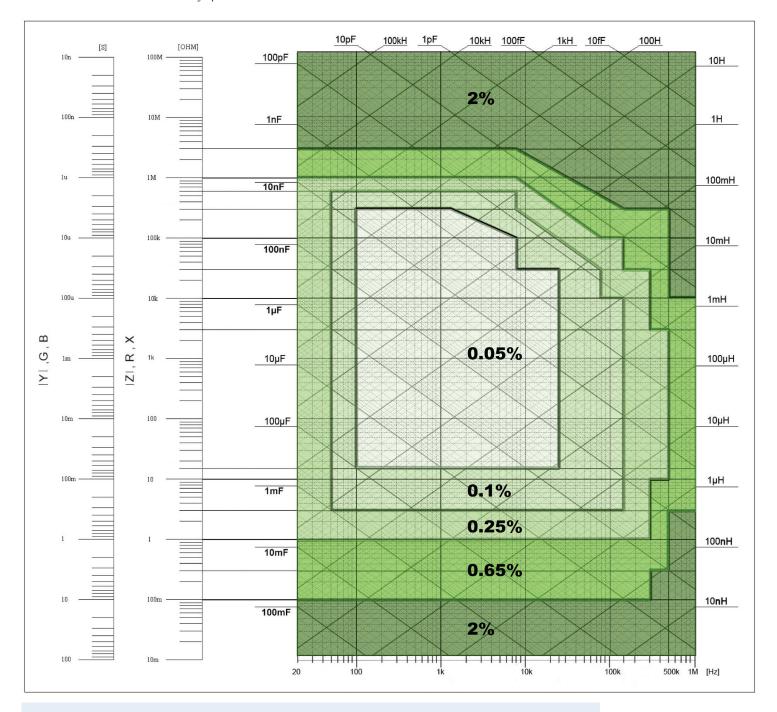
Optional accessories

Transformer test fixture TL89T1

Measurement Accuracy

The chart below depicts the basic measurement accuracy under the following conditions: AC test signal level 0.5 Vrms or 1 Vrms, measurement speed Slow or Medium, cable length 0 m, DC bias OFF, $Dx \le 0.1$ or $Qx \le 0.1$ respectively. When selecting measurement speed Fast, double the accuracy value obtained from the chart.

For more detailed measurement accuracy specifications and other test conditions, refer to the user manual.



DCR Accuracy: $A(1 + Rx / 5 M\Omega + 16 m\Omega / Rx)[\%] \pm 0.2 m\Omega$ A=0.25 for slow & medium speed, A=0.5 for fast speed